

客户名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	WAN3216F245L08
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type 08
版本 VERSION	:	V4.0
日期 ISSUE DATE	:	2020/02/24



	工程部 R&D CENTER	
承 認 APPROVAL	確認 CHECKED	製 作 DRAWN
Ray	Tennyson	Chun



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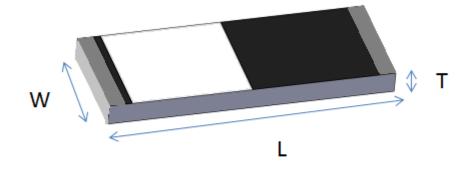
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3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245L08

	Dimension (mm)			
L	3.23 ± 0.20			
W	1.66 ± 0.20			
Т	0.45 ± 0.20			

Part Number Information

WA	<u>AN</u> 3	<u>8216</u>	<u></u>	<u>245</u>	L	<u>08</u>
A	A	В	С	D	Ε	F
	_					
A Product Series			Antenna			
B	Dimension L x W		3.2 x 1.6mm (±0.2mm)			
С	Material			Hi	gh K mate	erial
D	D Working Frequency		2	.4 ~ 2.5G	Hz	
Ε	Feeding mode			Loop & Single Feeding		
F	Antenna type				Type = 0	8

1. Electrical Specification

Specification				
Part Number	WAN3216F245L08			
Central Frequency	2450	MHz		
Bandwidth	110 (Min.)	MHz		
Return Loss	-10 (Max)	dB		
Peak Gain	1.15	dBi		
Impedance	50	Ohm		
Operating Temperature	-40~+110	°C		
Maximum Power	4	W		
Resistance to Soldering Heats	10 (@ 260°C)	sec.		
Polarization	Linear			
Azimuth Beamwidth	Omni-directional			
Termination	Ni / Au (Leadless)			

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

2. Recommended PCB Pattern Evaluation Board Dimension





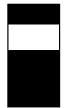
Suggested Matching Circuit

<u>重要資訊</u>: 匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



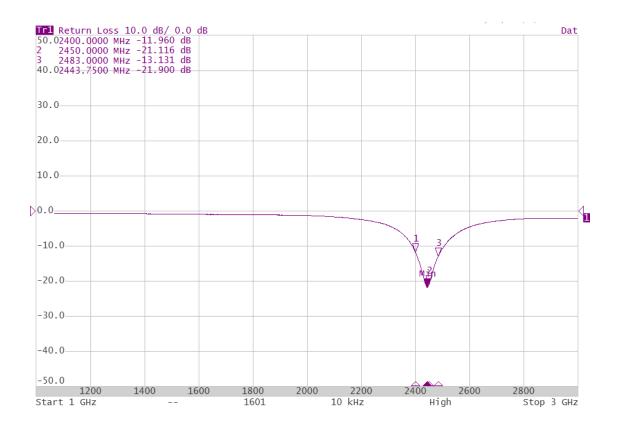
Layout Dimensions in Clearance area(Size=5.8*9.9mm)



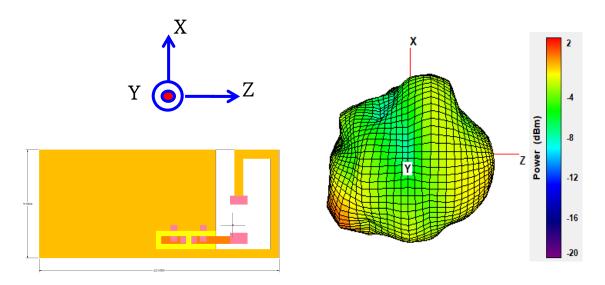




3. Measurement Results Return Loss

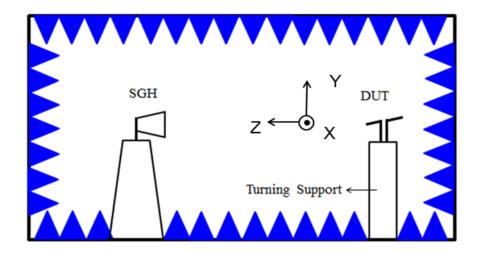


Radiation Pattern



	Efficiency	Peak Gain	Directivity
2400MHz	64.38 %	1.04 dBi	2.95 dBi
2450MHz	68.15 %	1.15 dBi	2.81 dBi
2500MHz	66.68 %	1.12 dBi	2.88 dBi

Chamber Coordinate System





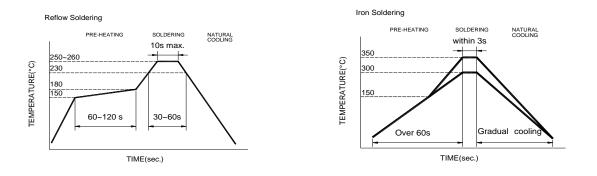
4.Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION
Solderability	1. Wetting shall exceed 90% coverage	Pre-heating temperature:150°C/60sec.
Soluciusiity	2. No visible mechanical damage	Solder temperature:230 \pm 5 $^{\circ}$ C
		Duration:4±1sec.
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5
	4±1 sec.	Flux for lead free: rosin
	230°C 4±1 sec.	
	150°C	
	60sec	
	> 00sec (
Solder heat Resistance	 No visible mechanical damage Central Freq. change :within ± 6% 	Pre-heating temperature:150°C/60sec.
Resistance		Solder temperature:260±5°C
	TEMP (°C)	Duration:10±0.5sec.
	260°C 10±0.5 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin
		Flux for lead free. Toshi
	150°C	
	60sec	
Component	1. No visible mechanical damage	The device should be reflow
Adhesion (Push test)		soldered(230 \pm 5 $^{\circ}$ C for 10sec.) to a tinned
(Fush lest)		copper substrate A dynometer force
		gauge should be applied the side of the
		component. The device must with-ST-F 0.5 Kg without failure of the termination
		attached to component.
Component	1. No visible mechanical damage	Insert 10cm wire into the remaining open
Adhesion		eye bend ,the ends of even wire lengths
(Pull test)		upward and wind together.
(i un tost)		Terminal shall not be remarkably
		damaged.
Thermal shock	1. No visible mechanical damage	+110°C=>30±3min
		-40°C=>30±3min
	2. Central Freq. change :within ±6%	Test cycle:10 cycles
	Phase Temperature(℃) Time(min)	The chip shall be stabilized at normal
	1 +110±5℃ 30±3	condition for 2~3 hours before
	2 Room Within	measuring.
	Temperature 3sec	
	3 -40±2℃ 30±3	
	4 Room Within	
	Temperature 3sec	
Resistance to	1. No visible mechanical damage	Temperature:+110±5℃
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
Resistance to	1. No visible mechanical damage	Temperature:-40±5℃
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
Humidity	1. No visible mechanical damage	Temperature: 40±2°C
		Humidity: 90% to 95% RH
	2. Central Freq. change :within ±6%	-
		Duration: 1000±12hrs
	 Central Freq. change :within ±6% No disconnection or short circuit. 	Duration: 1000±12hrs The chip shall be stabilized at normal
		Duration: 1000±12hrs

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5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



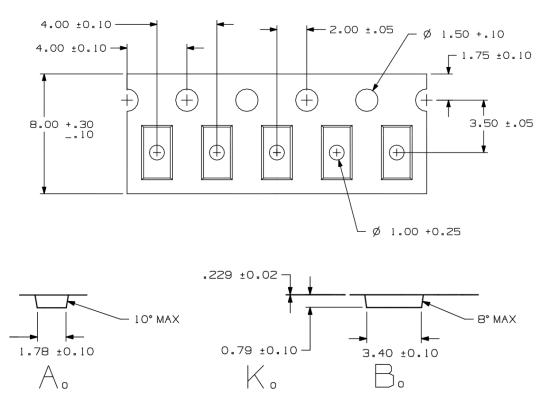
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

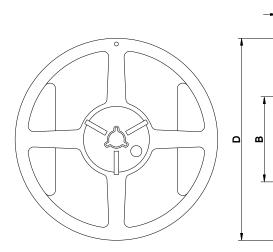
- Preheat circuit and products to 150° C
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

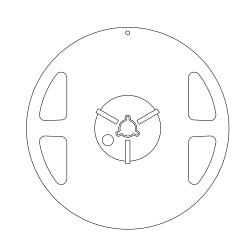
6.Packaging Information

Tape Specification:



Reel Specification: (7", Ф180 mm)





7" x 8 mm

C

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000

7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40° C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.